

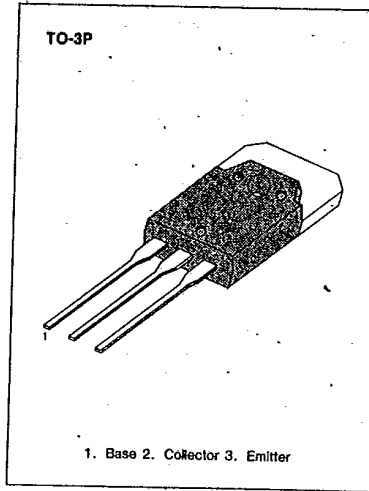
**KSC2751****NPN EPITAXIAL SILICON TRANSISTOR**

T-33-13

**HIGH SPEED, HIGH CURRENT SWITCHING  
INDUSTRIAL USE****ABSOLUTE MAXIMUM RATINGS (T<sub>a</sub> = 25°C)**

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V <sub>CE0</sub>	500	V
Collector-Emitter Voltage	V <sub>CE0</sub>	400	V
Emitter-Base Voltage	V <sub>EB0</sub>	7	V
Collector Current (DC)	I <sub>C</sub>	15	A
*Collector Current (Pulse)	I <sub>C</sub>	30	A
Base Current (DC)	I <sub>B</sub>	7.5	A
Collector Dissipation (T <sub>c</sub> = 25°C)	P <sub>C</sub>	120	W
Junction Temperature	T <sub>J</sub>	150	°C
Storage Temperature	T <sub>stg</sub>	-55~150	°C

\* PW ≤ 300μs, Duty Cycle ≤ 10%



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**ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = 25°C)**

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Emitter Sustaining Voltage	V <sub>CE0</sub> (sus)	I <sub>C</sub> = 10A, I <sub>B</sub> = 2A, L = 50μH	400			V
Collector Emitter Sustaining Voltage	V <sub>CE0</sub> (sus)1	I <sub>C</sub> = 10A, I <sub>B1</sub> = -I <sub>B2</sub> = 2A T <sub>a</sub> = 125°C, L = 180μH, Clamped	450			V
Collector Emitter Sustaining Voltage	V <sub>CE0</sub> (sus)2	I <sub>C</sub> = 20A, I <sub>B1</sub> = 4A, -I <sub>B2</sub> = 2A T <sub>a</sub> = 125°C, L = 180μH, Clamped	400			V
Collector Cutoff Current	I <sub>CE0</sub>	V <sub>CE</sub> = 400V, I <sub>E</sub> = 0			100	μA
Collector Cutoff Current	I <sub>CER</sub>	V <sub>CE</sub> = 400V, R <sub>BE</sub> = 50Ω, T <sub>a</sub> = 125°C			2	mA
Collector Cutoff Current	I <sub>CEX1</sub>	V <sub>CE</sub> = 400V, V <sub>BE</sub> (off) = -1.5V			100	μA
Collector Cutoff Current	I <sub>CEX2</sub>	V <sub>CE</sub> = 400V, V <sub>BE</sub> (off) = -1.5V T <sub>a</sub> = 125°C			1	mA
Emitter Cutoff Current	I <sub>EB0</sub>	V <sub>EB</sub> = 5V, I <sub>C</sub> = 0			10	μA
*DC Current Gain	h <sub>FE1</sub>	V <sub>CE</sub> = 5V, I <sub>C</sub> = 2A	15	35	80	
	h <sub>FE2</sub>	V <sub>CE</sub> = 5V, I <sub>C</sub> = 5A	10			
	h <sub>FE3</sub>	V <sub>CE</sub> = 5V, I <sub>C</sub> = 10A	7			
*Collector-Emitter Saturation Voltage	V <sub>CE</sub> (sat)	I <sub>C</sub> = 10A, I <sub>B</sub> = 2A		0.3	1	V
*Base-Emitter Saturation Voltage	V <sub>BE</sub> (sat)	I <sub>C</sub> = 10A, I <sub>B</sub> = 2A		1	1.5	V
Turn On Time	t <sub>on</sub>	I <sub>C</sub> = 10A, R <sub>L</sub> = 15Ω			1	μs
Storage Time	t <sub>s</sub>	I <sub>B1</sub> = -I <sub>B2</sub> = 2A, V <sub>CC</sub> = 150V			2.5	μs
Fall Time	t <sub>f</sub>				0.7	μs

\*Pulse Test: PW ≤ 350μs, Duty Cycle ≤ 2% Pulsed

**h<sub>FE</sub> (1) CLASSIFICATION**

Classification	N	R	O	Y
h <sub>FE</sub> (1)	15-30	20-40	30-60	40-80

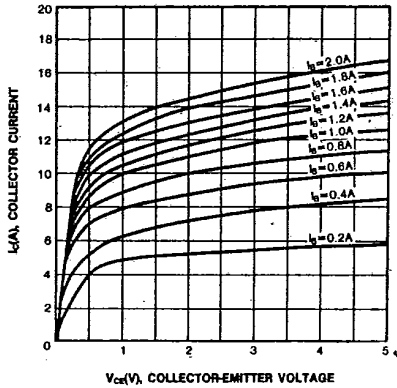


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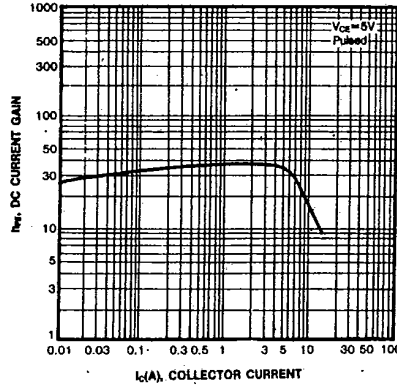
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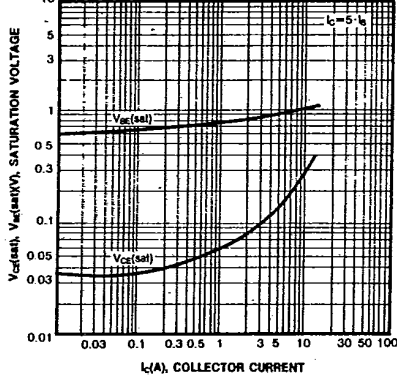
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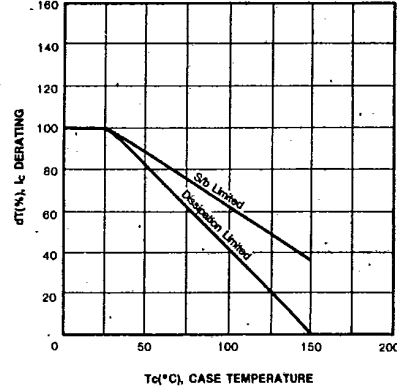
DC CURRENT GAIN



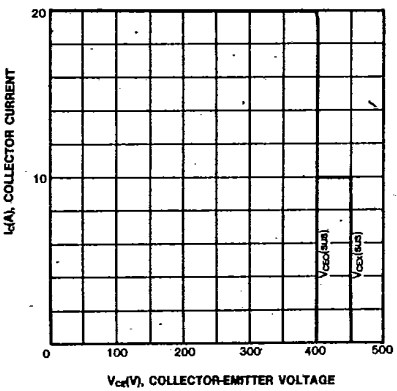
BASE-EMITTER SATURATION VOLTAGE  
COLLECTOR-EMITTER SATURATION VOLTAGE



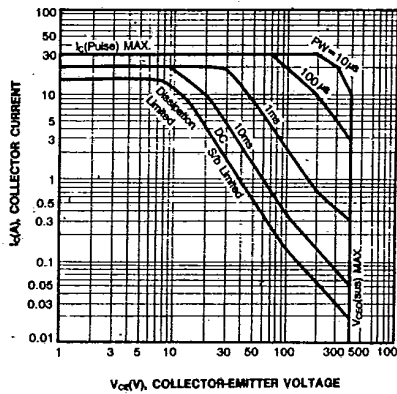
DERATING CURVE OF SAFE OPERATING AREAS



REVERSE BIAS SAFE OPERATING AREA



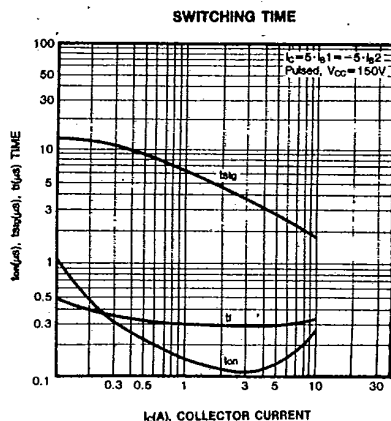
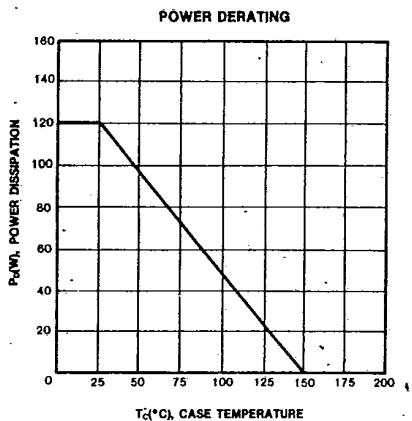
SAFE OPERATING AREA



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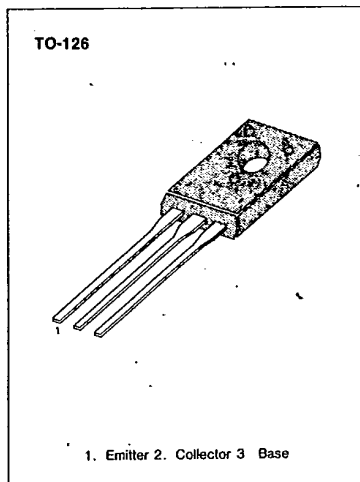
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**KSC2752****NPN EPITAXIAL SILICON TRANSISTOR**

T-33-07

**HIGH SPEED, HIGH VOLTAGE SWITCHING  
INDUSTRIAL USE****ABSOLUTE MAXIMUM RATINGS (T<sub>a</sub>=25°C)**

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V <sub>CB0</sub>	500	V
Collector-Emitter Voltage	V <sub>CEO</sub>	400	V
Emitter-Base Voltage	V <sub>EB0</sub>	7	V
Collector Current (DC)	I <sub>C</sub>	0.5	A
*Collector Current (Pulse)	I <sub>C</sub>	1	A
Base Current (DC)	I <sub>B</sub>	0.25	A
Collector Dissipation (T <sub>a</sub> =25°C)	P <sub>C</sub>	1	W
Collector Dissipation (T <sub>c</sub> =25°C)	P <sub>C</sub>	10	W
Junction Temperature	T <sub>J</sub>	150	°C
Storage Temperature	T <sub>stg</sub>	-55~150	°C



\* PW≤300μs, Duty Cycle ≤10%

**ELECTRICAL CHARACTERISTICS (T<sub>a</sub>=25°C)**

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Emitter Sustaining Voltage	V <sub>CEO (sus)</sub>	I <sub>C</sub> =0.3A, I <sub>B1</sub> =0.06A, L=10mH	400		V
Collector Emitter Sustaining Voltage	V <sub>CEX (sus)1</sub>	I <sub>C</sub> =0.3A, I <sub>B1</sub> =-I <sub>B2</sub> =0.06A V <sub>BE (off)</sub> =-5V, L=10mH, Clamped	450		V
Collector Emitter Sustaining Voltage	V <sub>CEX (sus)2</sub>	I <sub>C</sub> =0.6A, I <sub>B1</sub> =0.2A, I <sub>B2</sub> =-0.06A V <sub>BE (off)</sub> =-5V, L=10mH, Clamped	400		V
Collector Cutoff Current	I <sub>CBO</sub>	V <sub>CB</sub> =400V, I <sub>E</sub> =0		10	μA
Collector Cutoff Current	I <sub>CER</sub>	V <sub>CE</sub> =400V, R <sub>BE</sub> =51Ω, T <sub>a</sub> =125°C		1	mA
Collector Cutoff Current	I <sub>CEX1</sub>	V <sub>CE</sub> =400V, V <sub>BE (off)</sub> =-1.5V		10	μA
Collector Cutoff Current	I <sub>CEX2</sub>	V <sub>CE</sub> =400V, V <sub>BE (off)</sub> =-1.5V T <sub>a</sub> =125°C		1	mA
Emitter Cutoff Current	I <sub>EB0</sub>	V <sub>EB</sub> =5V, I <sub>C</sub> =0		10	μA
*DC Current Gain	h <sub>FE1</sub>	V <sub>CE</sub> =5V, I <sub>C</sub> =0.05A	20	80	
	h <sub>FE2</sub>	V <sub>CE</sub> =5V, I <sub>C</sub> =0.3A	10		
*Collector-Emitter Saturation Voltage	V <sub>CE (sat)</sub>	I <sub>C</sub> =0.3A, I <sub>B</sub> =0.06A		1	V
*Base-Emitter Saturation Voltage	V <sub>BE (sat)</sub>	I <sub>C</sub> =0.3A, I <sub>B</sub> =0.06A		1.2	V
Turn On Time	t <sub>on</sub>	I <sub>C</sub> =0.3A RL=500Ω		1	μs
Storage Time	t <sub>s</sub>	I <sub>B1</sub> =-I <sub>B2</sub> =0.06A, V <sub>CC</sub> =150V		2.5	μs
Fall Time	t <sub>f</sub>	PW=50μs, Duty Cycle≤2%		1	μs

\*Pulse Test: PW≤350μs, Duty Cycle≤2% pulsed

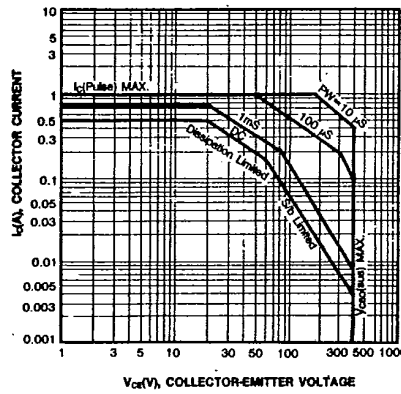
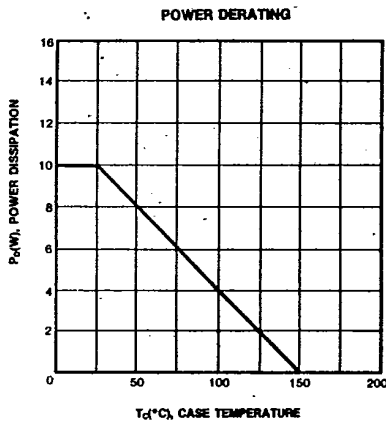
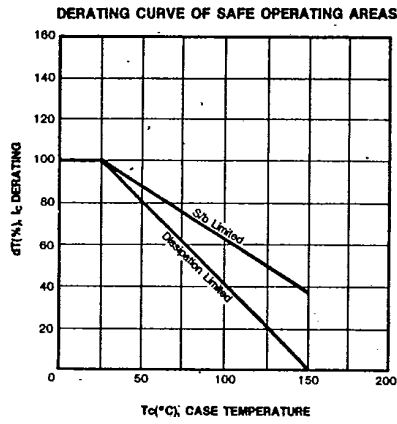
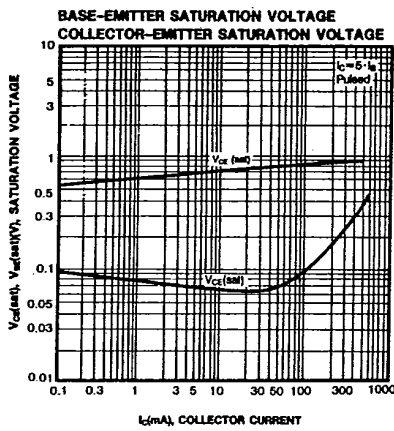
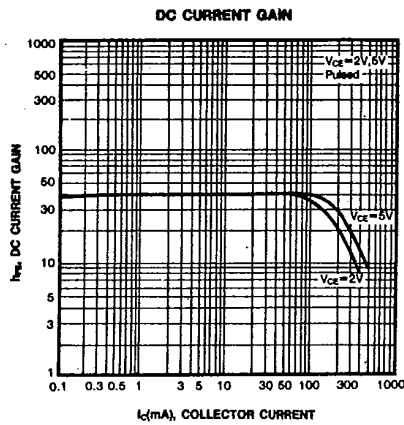
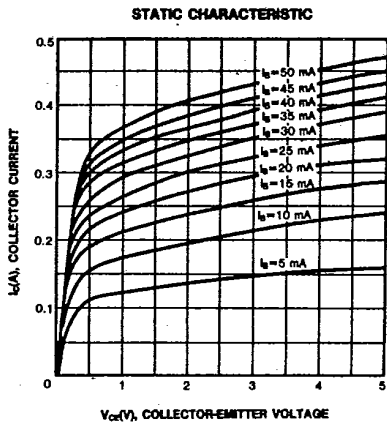
**h<sub>FE</sub> (1) CLASSIFICATION**

Classification	R	O	Y
h <sub>FE</sub> (1)	20-40	30-60	40-80

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